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Details

Product Status	Obsolete
Core Processor	HC08
Core Size	8-Bit
Speed	8MHz
Connectivity	LINbus, SCI, SPI
Peripherals	POR, PWM
Number of I/O	24
Program Memory Size	8KB (8K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	512 x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 8x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	32-LQFP
Supplier Device Package	32-LQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mc908ey8amfje

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2.6.3 FLASH Mass Erase Operation

Use this step-by-step procedure to erase entire FLASH memory to read as logic 1:

1. Set both the ERASE bit and the MASS bit in the FLASH control register.
2. Read the FLASH block protect register.
3. Write any data to any FLASH address⁽¹⁾ within the FLASH memory address range.
4. Wait for a time, t_{NVS} (minimum 10 μ s).
5. Set the HVEN bit.
6. Wait for a time, t_{MErase} (minimum 4 ms).
7. Clear the ERASE and MASS bits.

NOTE

Mass erase is disabled whenever any block is protected (FLBPR does not equal \$FF).

8. Wait for a time, t_{NVHL} (minimum 100 μ s).
9. Clear the HVEN bit.
10. After time, t_{RCV} (typical 1 μ s), the memory can be accessed in read mode again.

NOTE

Programming and erasing of FLASH locations cannot be performed by code being executed from the FLASH memory. While these operations must be performed in the order as shown, but other unrelated operations may occur between the steps.

1. When in monitor mode, with security sequence failed (see [19.3.2 Security](#)), write to the FLASH block protect register instead of any FLASH address.

break, the bit cannot change during the break state as long as BCFE is cleared. After the break, doing the second step clears the status bit.

3.7 I/O Signals

The ADC10 module shares its pins with general-purpose input/output (I/O) port pins. See [Figure 3-1](#) for port location of these shared pins. The ADC10 on this MCU uses V_{DD} and V_{SS} as its supply and reference pins. This MCU does not have an external trigger source.

3.7.1 ADC10 Analog Power Pin (V_{DDA})

The ADC10 analog portion uses V_{DDA} as its power pin. In some packages, V_{DDA} is connected internally to V_{DD} . If externally available, connect the V_{DDA} pin to the same voltage potential as V_{DD} . External filtering may be necessary to ensure clean V_{DDA} for good results.

NOTE

If externally available, route V_{DDA} carefully for maximum noise immunity and place bypass capacitors as near as possible to the package.

3.7.2 ADC10 Analog Ground Pin (V_{SSA})

The ADC10 analog portion uses V_{SSA} as its ground pin. In some packages, V_{SSA} is connected internally to V_{SS} . If externally available, connect the V_{SSA} pin to the same voltage potential as V_{SS} .

In cases where separate power supplies are used for analog and digital power, the ground connection between these supplies should be at the V_{SSA} pin. This should be the only ground connection between these supplies if possible. The V_{SSA} pin makes a good single point ground location.

3.7.3 ADC10 Voltage Reference High Pin (V_{REFH})

V_{REFH} is the power supply for setting the high-reference voltage for the converter. In some packages, V_{REFH} is connected internally to V_{DDA} . If externally available, V_{REFH} may be connected to the same potential as V_{DDA} , or may be driven by an external source that is between the minimum V_{DDA} spec and the V_{DDA} potential (V_{REFH} must never exceed V_{DDA}).

NOTE

Route V_{REFH} carefully for maximum noise immunity and place bypass capacitors as near as possible to the package.

AC current in the form of current spikes required to supply charge to the capacitor array at each successive approximation step is drawn through the V_{REFH} and V_{REFL} loop. The best external component to meet this current demand is a 0.1 μF capacitor with good high frequency characteristics. This capacitor is connected between V_{REFH} and V_{REFL} and must be placed as close as possible to the package pins. Resistance in the path is not recommended because the current will cause a voltage drop which could result in conversion errors. Inductance in this path must be minimum (parasitic only).

3.7.4 ADC10 Voltage Reference Low Pin (V_{REFL})

V_{REFL} is the power supply for setting the low-reference voltage for the converter. In some packages, V_{REFL} is connected internally to V_{SSA} . If externally available, connect the V_{REFL} pin to the same voltage potential as V_{SSA} . There will be a brief current associated with V_{REFL} when the sampling capacitor is

7.3.5 Condition Code Register

The 8-bit condition code register contains the interrupt mask and five flags that indicate the results of the instruction just executed. Bits 6 and 5 are set permanently to 1. The following paragraphs describe the functions of the condition code register.

	Bit 7	6	5	4	3	2	1	Bit 0
Read:	V	1	1	H	I	N	Z	C
Write:								
Reset:	X	1	1	X	1	X	X	X

X = Indeterminate

Figure 7-6. Condition Code Register (CCR)

V — Overflow Flag

The CPU sets the overflow flag when a two's complement overflow occurs. The signed branch instructions BGT, BGE, BLE, and BLT use the overflow flag.

- 1 = Overflow
- 0 = No overflow

H — Half-Carry Flag

The CPU sets the half-carry flag when a carry occurs between accumulator bits 3 and 4 during an add-without-carry (ADD) or add-with-carry (ADC) operation. The half-carry flag is required for binary-coded decimal (BCD) arithmetic operations. The DAA instruction uses the states of the H and C flags to determine the appropriate correction factor.

- 1 = Carry between bits 3 and 4
- 0 = No carry between bits 3 and 4

I — Interrupt Mask

When the interrupt mask is set, all maskable CPU interrupts are disabled. CPU interrupts are enabled when the interrupt mask is cleared. When a CPU interrupt occurs, the interrupt mask is set automatically after the CPU registers are saved on the stack, but before the interrupt vector is fetched.

- 1 = Interrupts disabled
- 0 = Interrupts enabled

NOTE

To maintain M6805 Family compatibility, the upper byte of the index register (H) is not stacked automatically. If the interrupt service routine modifies H, then the user must stack and unstack H using the PSHH and PULH instructions.

After the I bit is cleared, the highest-priority interrupt request is serviced first.

A return-from-interrupt (RTI) instruction pulls the CPU registers from the stack and restores the interrupt mask from the stack. After any reset, the interrupt mask is set and can be cleared only by the clear interrupt mask software instruction (CLI).

N — Negative Flag

The CPU sets the negative flag when an arithmetic operation, logic operation, or data manipulation produces a negative result, setting bit 7 of the result.

- 1 = Negative result
- 0 = Non-negative result

Chapter 8

Internal Clock Generator (ICG) Module

8.1 Introduction

The internal clock generator (ICG) module is used to create a stable clock source for the microcontroller without using any external components. The ICG generates the oscillator output clock (CGMXCLK), which is used by the computer operating properly (COP), low-voltage inhibit (LVI), and other modules. The ICG also generates the clock generator output (CGMOUT), which is fed to the system integration module (SIM) to create the bus clocks. The bus frequency will be one-fourth the frequency of CGMXCLK and one-half the frequency of CGMOUT. Finally, the ICG generates the timebase clock (TBMCLK), which is used in the timebase module (TBM).

8.2 Features

The ICG has these features:

- Selectable external clock generator, either 1-pin external source or 2-pin crystal, multiplexed with port pins
- Internal clock generator with programmable frequency output in integer multiples of a nominal frequency (307.2 kHz \pm 25 percent)
- Internal oscillator trimmed accuracy of \pm 3.5 percent
- Bus clock software selectable from either internal or external clock (bus frequency range from 76.8 kHz \pm 25 percent to 9.75 MHz \pm 25 percent in 76.8-kHz increments)

NOTE

For the MC68HC908EY16A, do not exceed the maximum bus frequency of 8 MHz at 5.0 V.

- Timebase clock automatically selected from external clock if external clock is available
- Clock monitor for both internal and external clocks

8.3 Functional Description

The ICG, shown in [Figure 8-2](#), contains these major submodules:

- Clock enable circuit
- Internal clock generator
- External clock generator
- Clock monitor circuit
- Clock selection circuit

8.3.4.1 Clock Monitor Reference Generator

The clock monitor uses a reference based on one clock source to monitor the other clock source. The clock monitor reference generator generates the external reference clock (EREF) based on the external clock (ECLK) and the internal reference clock (IREF) based on the internal clock (ICLK). To simplify the circuit, the low-frequency base clock (IBASE) is used in place of ICLK because it always operates at or near 307.2 kHz. For proper operation, EREF must be at least twice as slow as IBASE and IREF must be at least twice as slow as ECLK.

To guarantee that IREF is slower than ECLK and EREF is slower than IBASE, one of the signals is divided down. Which signal is divided and by how much is determined by the external slow (EXTSLOW) and external crystal enable (EXTXTALEN) bits in the CONFIG, according to the rules in [Table 8-2](#).

NOTE

Each signal (IBASE and ECLK) is always divided by four. A longer divider is used on either IBASE or ECLK based on the EXTSLOW bit.

To conserve size, the long divider (divide by 4096) is also used as an external crystal stabilization divider. The divider is reset when the external clock generator is turned off or in stop mode (ECGEN is clear). When the external clock generator is first turned on, the external clock generator stable bit (ECGS) will be clear. This condition automatically selects ECLK as the input to the long divider. The external stabilization clock (ESTBCLK) will be ECLK divided by 16 when EXTXTALEN is low or 4096 when EXTXTALEN is high. This timeout allows the crystal to stabilize. The falling edge of ESTBCLK is used to set ECGS, which will set after a full 16 or 4096 cycles. When ECGS is set, the divider returns to its normal function. ESTBCLK may be generated by either IBASE or ECLK, but any clocking will only reinforce the set condition. If ECGS is cleared because the clock monitor determined that ECLK was inactive, the divider will revert to a stabilization divider. Since this will change the EREF and IREF divide ratios, it is important to turn the clock monitor off (CMON = 0) after inactivity is detected to ensure valid recovery.

8.3.4.2 Internal Clock Activity Detector

The internal clock activity detector, shown in [Figure 8-6](#), looks for at least one falling edge on the low-frequency base clock (IBASE) every time the external reference (EREF) is low. Since EREF is less than half the frequency of IBASE, this should occur every time. If it does not occur two consecutive times, the internal clock inactivity indicator (IOFF) is set. IOFF will be cleared the next time there is a falling edge of IBASE while EREF is low.

The internal clock stable bit (ICGS) is also generated in the internal clock activity detector. ICGS is set when the internal clock generator's filter stable signal (FICGS) indicates that IBASE is within about 5 percent of the target 307.2 kHz \pm 25 percent for two consecutive measurements. ICGS is cleared when FICGS is clear, the internal clock generator is turned off or is in stop mode (ICGEN is clear), or when IOFF is set.

8.3.4.3 External Clock Activity Detector

The external clock activity detector, shown in [Figure 8-7](#), looks for at least one falling edge on the external clock (ECLK) every time the internal reference (IREF) is low. Since IREF is less than half the frequency of ECLK, this should occur every time. If it does not occur two consecutive times, the external clock inactivity indicator (EOFF) is set. EOFF will be cleared the next time there is a falling edge of ECLK while IREF is low.

12.3 Port B

Port B is an 8-bit special-function port that shares all of its pins with the analog-to-digital converter (ADC) and some pin functions with TIMB.

Port B is designed so that the ADC function will take priority over the timer functionality on PTB6 and PTB7. If the ADC is selected for a conversion on a previously enabled timer pin, the port pin will be connected to the ADC and disconnected from the timer. If both the timer input capture and ADC functions are being used on the same port pin, it is recommended that the timer channel be disabled before the pin is enabled as an ADC input to avoid glitches. If both the timer output compare (or PWM) and ADC functions are being used on the same port pin, it is recommended that the timer channel be disabled before the pin is enabled as an ADC input.

12.3.1 Port B Data Register

The port B data register contains a data latch for each of the eight port B pins.

Address:	\$0001							
	Bit 7	6	5	4	3	2	1	Bit 0
Read:	PTB7	PTB6	PTB5	PTB4	PTB3	PTB2	PTB1	PTB0
Write:								
Reset:	Unaffected by reset							
Alternative Function:	AD7	AD6	AD5	AD4	AD3	AD2	AD1	AD0
Alternative Function:	TBCH1	TBCH0	SPSCK	MOSI	MISO			

Figure 12-4. Port B Data Register (PTB)

PTB[7:0] — Port B Data Bits

These read/write bits are software programmable. Data direction of each port B pin is under the control of the corresponding bit in data direction register B. Reset has no effect on port B data.

12.3.2 Data Direction Register B

Data direction register B determines whether each port B pin is an input or an output. Writing a 1 to a DDRB bit enables the output buffer for the corresponding port B pin; a 0 disables the output buffer.

Address:	\$0005							
	Bit 7	6	5	4	3	2	1	Bit 0
Read:	DDRB7	DDRB6	DDRB5	DDRB4	DDRB3	DDRB2	DDRB1	DDRB0
Write:								
Reset:	0	0	0	0	0	0	0	0

Figure 12-5. Data Direction Register B (DDRB)

DDRB[7:0] — Data Direction Register B Bits

These read/write bits control port B data direction. Reset clears DDRB[7:0], configuring all port B pins as inputs.

1 = Corresponding port B pin configured as output

0 = Corresponding port B pin configured as input

NOTE

Avoid glitches on port B pins by writing to the port B data register before changing data direction register B bits from 0 to 1.

RPF — Reception in Progress Flag Bit

This read-only bit is set when the receiver detects a 0 during the RT1 time period of the start bit search. RPF does not generate an interrupt request. RPF is reset after the receiver detects false start bits (usually from noise or a baud rate mismatch), or when the receiver detects an idle character. Polling RPF before disabling the ESCI module or entering stop mode can show whether a reception is in progress.

- 1 = Reception in progress
- 0 = No reception in progress

13.8.6 ESCI Data Register

The ESCI data register (SCDR) is the buffer between the internal data bus and the receive and transmit shift registers. Reset has no effect on data in the ESCI data register.

Address: \$0015

	Bit 7	6	5	4	3	2	1	Bit 0
Read:	R7	R6	R5	R4	R3	R2	R1	R0
Write:	T7	T6	T5	T4	T3	T2	T1	T0
Reset:	Unaffected by Reset							

Figure 13-15. ESCI Data Register (SCDR)

R7/T7:R0/T0 — Receive/Transmit Data Bits

Reading address \$0018 accesses the read-only received data bits, R7:R0. Writing to address \$0018 writes the data to be transmitted, T7:T0. Reset has no effect on the ESCI data register.

NOTE

Do not use read-modify-write instructions on the ESCI data register.

13.8.7 ESCI Baud Rate Register

The ESCI baud rate register (SCBR) together with the ESCI prescaler register selects the baud rate for both the receiver and the transmitter.

NOTE

There are two prescalers available to adjust the baud rate. One in the ESCI baud rate register and one in the ESCI prescaler register.

Address: \$0016

	Bit 7	6	5	4	3	2	1	Bit 0
Read:	LINT	LINR	SCP1	SCP0	R	SCR2	SCR1	SCR0
Write:								
Reset:	0	0	0	0	0	0	0	0

R = Reserved

Figure 13-16. ESCI Baud Rate Register (SCBR)

LINT — LIN Break Symbol Transmit Enable

This read/write bit selects the enhanced ESCI features for master nodes in the local interconnect network (LIN) protocol (version 1.2) as shown in [Table 13-6](#). Reset clears LINT.

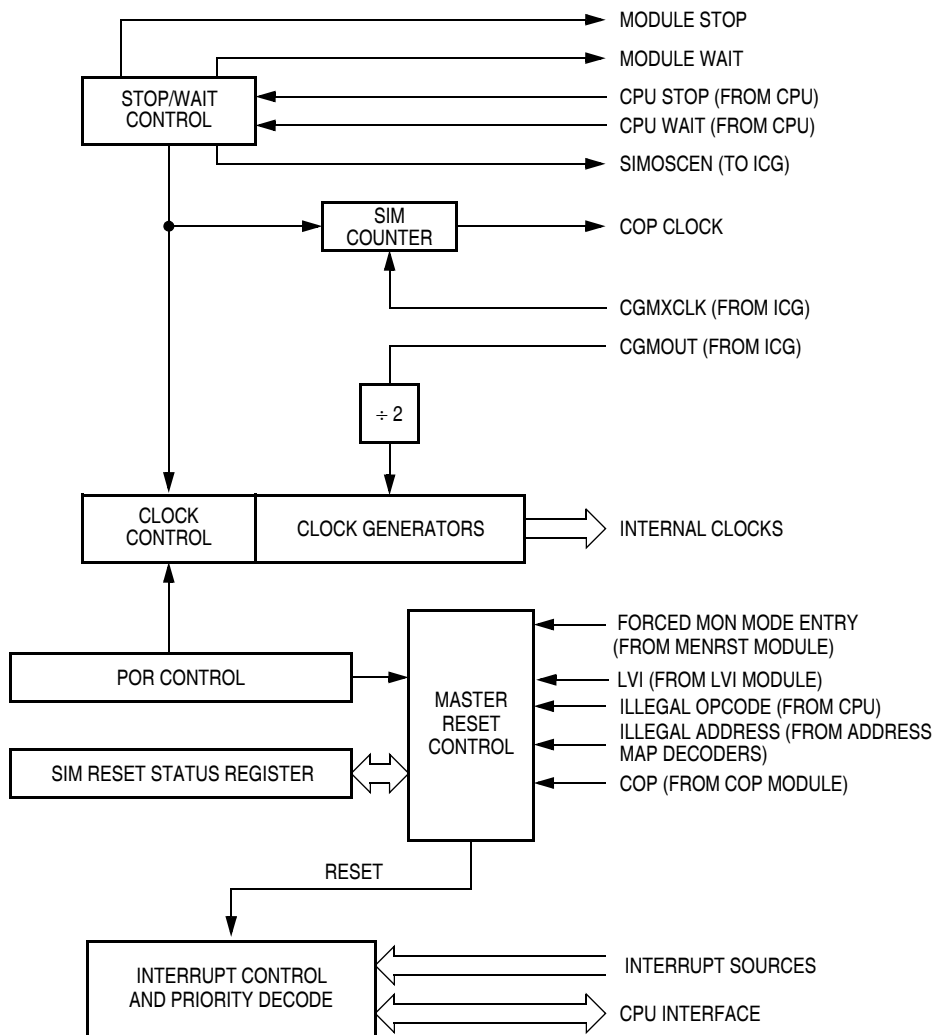


Figure 14-1. SIM Block Diagram

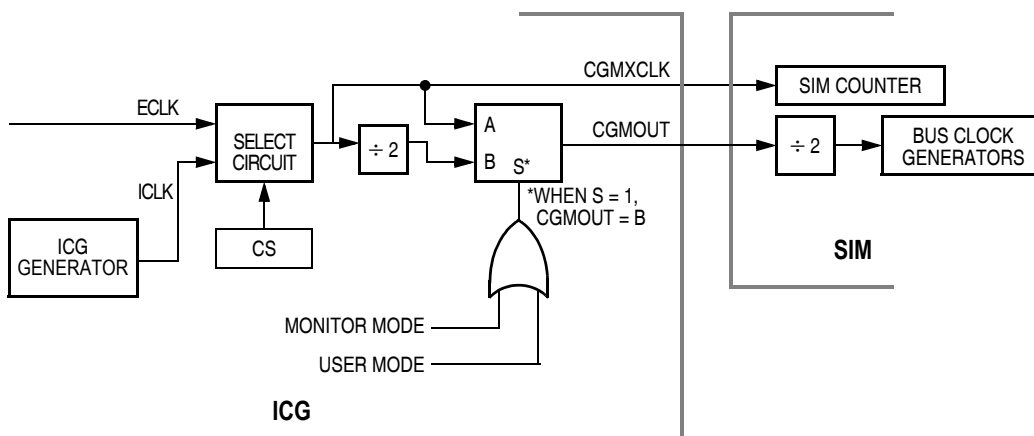


Figure 14-2. System Clock Signals

14.5.1 Interrupts

At the beginning of an interrupt, the CPU saves the CPU register contents on the stack and sets the interrupt mask (I bit) to prevent additional interrupts. At the end of an interrupt, the return-from-interrupt (RTI) instruction recovers the CPU register contents from the stack so that normal processing can resume. [Figure 14-7](#) shows interrupt entry timing. [Figure 14-8](#) shows interrupt recovery timing.

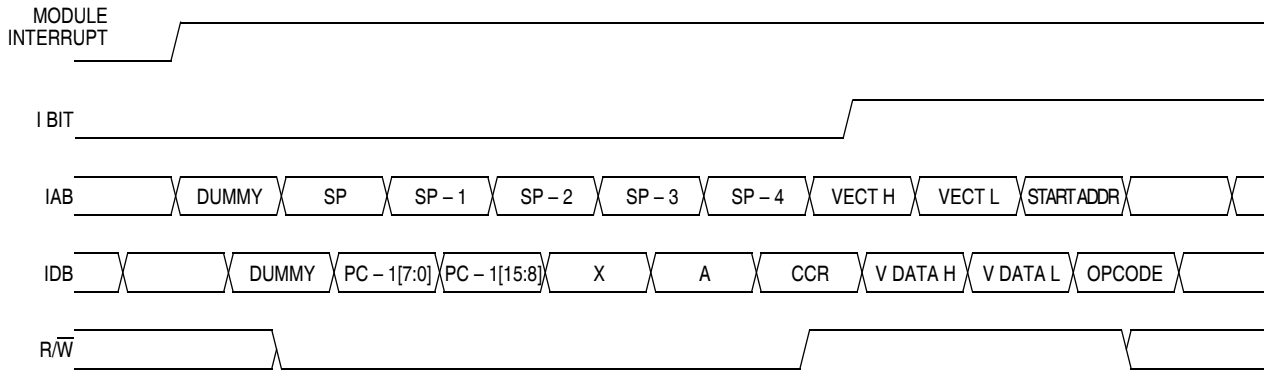


Figure 14-7. Interrupt Entry

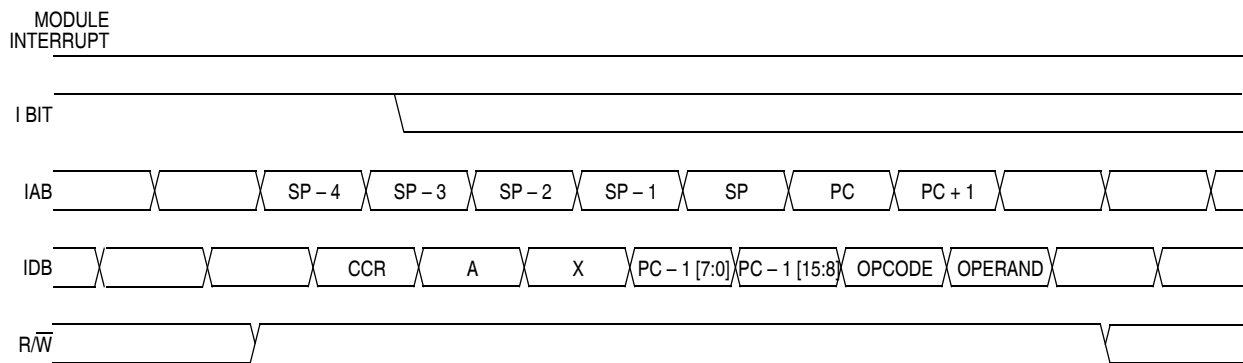
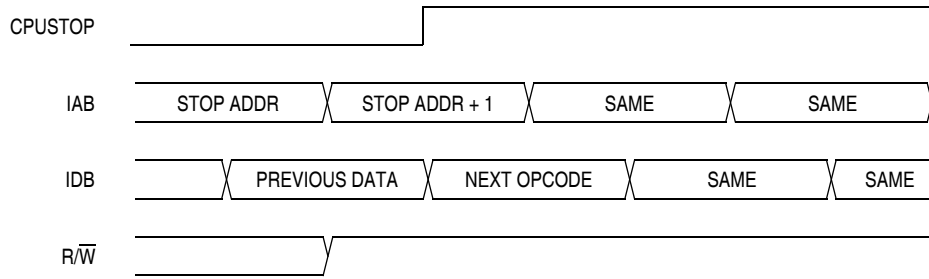


Figure 14-8. Interrupt Recovery

Interrupts are latched, and arbitration is performed in the SIM at the start of interrupt processing. The arbitration result is a constant that the CPU uses to determine which vector to fetch. As shown in [Figure 14-9](#), once an interrupt is latched by the SIM, no other interrupt can take precedence, regardless of priority, until the latched interrupt is serviced or the I bit is cleared.



Note: Previous data can be operand data or the STOP opcode, depending on the last instruction.

Figure 14-17. Stop Mode Entry Timing

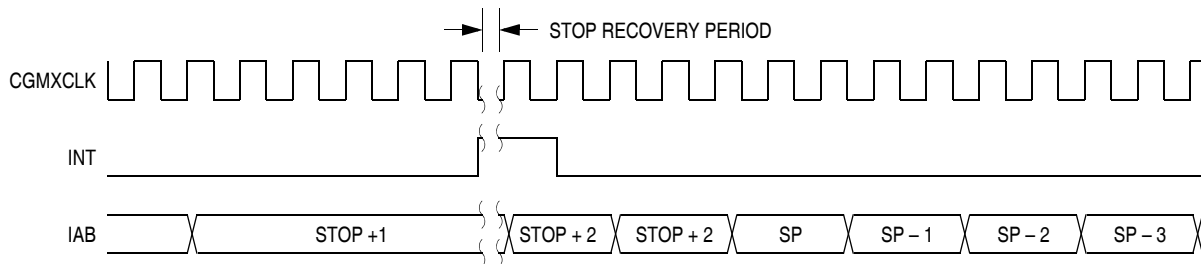


Figure 14-18. Stop Mode Recovery from Interrupt

14.8 SIM Registers

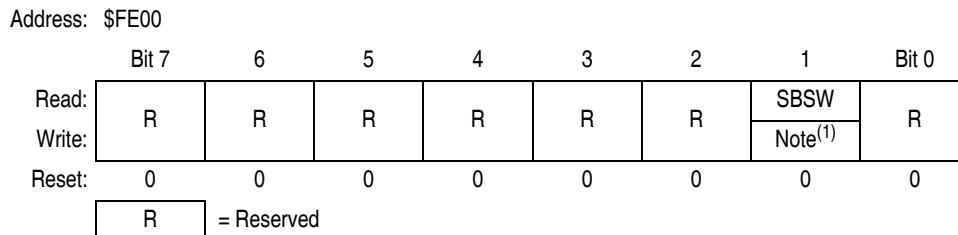
The SIM has three memory mapped registers. [Table 14-4](#) shows the mapping of these registers.

Table 14-4. SIM Registers

Address	Register	Access Mode
\$FE00	SBSR	User
\$FE01	SRSR	User
\$FE03	SBFCR	User

14.8.1 SIM Break Status Register

The SIM break status register (SBSR) contains a flag to indicate that a break caused an exit from stop or wait mode.



Note: 1. Writing a 0 clears SBSW

Figure 14-19. SIM Break Status Register (SBSR)

the slave data register must be loaded with the desired transmit data before the falling edge of \overline{SS} . Any data written after the falling edge is stored in the data register and transferred to the shift register at the current transmission.

When $CPHA = 1$ for a slave, the first edge of the $SPSCK$ indicates the beginning of the transmission. The same applies when \overline{SS} is high for a slave. The $MISO$ pin is held in a high-impedance state, and the incoming $SPSCK$ is ignored. In certain cases, it may also cause the $MODF$ flag to be set. (See [15.6.2 Mode Fault Error](#)). A logic 1 on the \overline{SS} pin does not in any way affect the state of the SPI state machine.

SPWOM — SPI Wired-OR Mode Bit

This read/write bit disables the pullup devices on pins $SPSCK$, $MOSI$, and $MISO$ so that those pins become open-drain outputs.

- 1 = Wired-OR $SPSCK$, $MOSI$, and $MISO$ pins
- 0 = Normal push-pull $SPSCK$, $MOSI$, and $MISO$ pins

SPE — SPI Enable Bit

This read/write bit enables the SPI module. Clearing SPE causes a partial reset of the SPI (see [15.9 Resetting the SPI](#)). Reset clears the SPE bit.

- 1 = SPI module enabled
- 0 = SPI module disabled

SPTIE — SPI Transmit Interrupt Enable Bit

This read/write bit enables CPU interrupt requests generated by the $SPTIE$ bit. $SPTIE$ is set when a byte transfers from the transmit data register to the shift register. Reset clears the $SPTIE$ bit.

- 1 = $SPTIE$ CPU interrupt requests enabled
- 0 = $SPTIE$ CPU interrupt requests disabled

15.13.2 SPI Status and Control Register

The SPI status and control register contains flags to signal the following conditions:

- Receive data register full
- Failure to clear $SPRF$ bit before next byte is received (overflow error)
- Inconsistent logic level on \overline{SS} pin (mode fault error)
- Transmit data register empty

The SPI status and control register also contains bits that perform these functions:

- Enable error interrupts
- Enable mode fault error detection
- Select master SPI baud rate

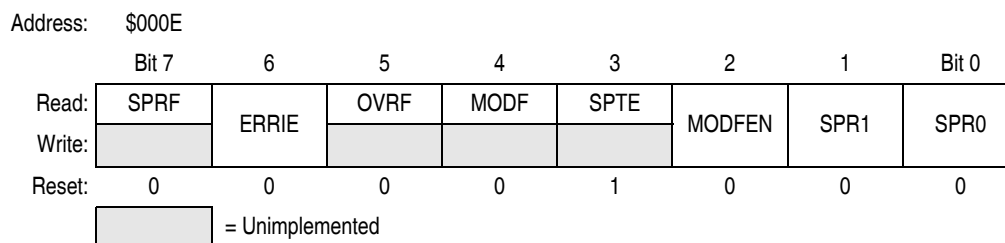


Figure 15-13. SPI Status and Control Register (SPSCR)

17.3.4.3 PWM Initialization

To ensure correct operation when generating unbuffered or buffered PWM signals, use this initialization procedure:

1. In the TIMA status and control register (TASC):
 - a. Stop the TIMA counter by setting the TIMA stop bit, TSTOP.
 - b. Reset the TIMA counter prescaler by setting the TIMA reset bit, TRST.
2. In the TIMA counter modulo registers (TAMODH–TAMODL), write the value for the required PWM period.
3. In the TIMA channel x registers (TACHxH–TACHxL), write the value for the required pulse width.
4. In TIMA channel x status and control register (TASCx):
 - a. Write 0:1 (for unbuffered output compare or PWM signals) or 1:0 (for buffered output compare or PWM signals) to the mode select bits, MSxB–MSxA. See [Table 17-2](#).
 - b. Write 1 to the toggle-on-overflow bit, TOVx.
 - c. Write 1:0 (to clear output on compare) or 1:1 (to set output on compare) to the edge/level select bits, ELSxB–ELSxA. The output action on compare must force the output to the complement of the pulse width level. See [Table 17-2](#).

NOTE

In PWM signal generation, do not program the PWM channel to toggle on output compare. Toggling on output compare prevents reliable 0% duty cycle generation and removes the ability of the channel to self-correct in the event of software error or noise. Toggling on output compare can also cause incorrect PWM signal generation when changing the PWM pulse width to a new, much larger value.

5. In the TIMA status control register (TASC), clear the TIMA stop bit, TSTOP.

Setting MS0B links channels 0 and 1 and configures them for buffered PWM operation. The TIMA channel 0 registers (TACH0H–TACH0L) initially control the buffered PWM output. TIMA status control register 0 (TASC0) controls and monitors the PWM signal from the linked channels. MS0B takes priority over MS0A.

Clearing the toggle-on-overflow bit, TOVx, inhibits output toggles on TIMA overflows. Subsequent output compares try to force the output to a state it is already in and have no effect. The result is a 0% duty cycle output.

Setting the channel x maximum duty cycle bit (CHxMAX) and setting the TOVx bit generates a 100% duty cycle output. See [17.8.4 TIMA Channel Status and Control Registers](#).

17.4 Interrupts

These TIMA sources can generate interrupt requests:

- TIMA overflow flag (TOF) — The TOF bit is set when the TIM counter reaches the modulo value programmed in the TIMA counter modulo registers. The TIMA overflow interrupt enable bit, TOIE, enables TIMA overflow CPU interrupt requests. TOF and TOIE are in the TIMA status and control register.
- TIMA channel flags (CH1F–CH0F) — The CHxF bit is set when an input capture or output compare occurs on channel x. Channel x TIMA CPU interrupt requests are controlled by the channel x interrupt enable bit, CHxIE.

18.8.5 TIMB Channel Registers

These read/write registers contain the captured TIMB counter value of the input capture function or the output compare value of the output compare function. The state of the TIMB channel registers after reset is unknown.

In input capture mode ($MSxB-MSxA = 0:0$), reading the high byte of the TIMB channel x registers (TBCHxH) inhibits input captures until the low byte (TBCHxL) is read.

In output compare mode ($MSxB-MSxA \neq 0:0$), writing to the high byte of the TIMB channel x registers (TBCHxH) inhibits output compares and the CHxF bit until the low byte (TBCHxL) is written.

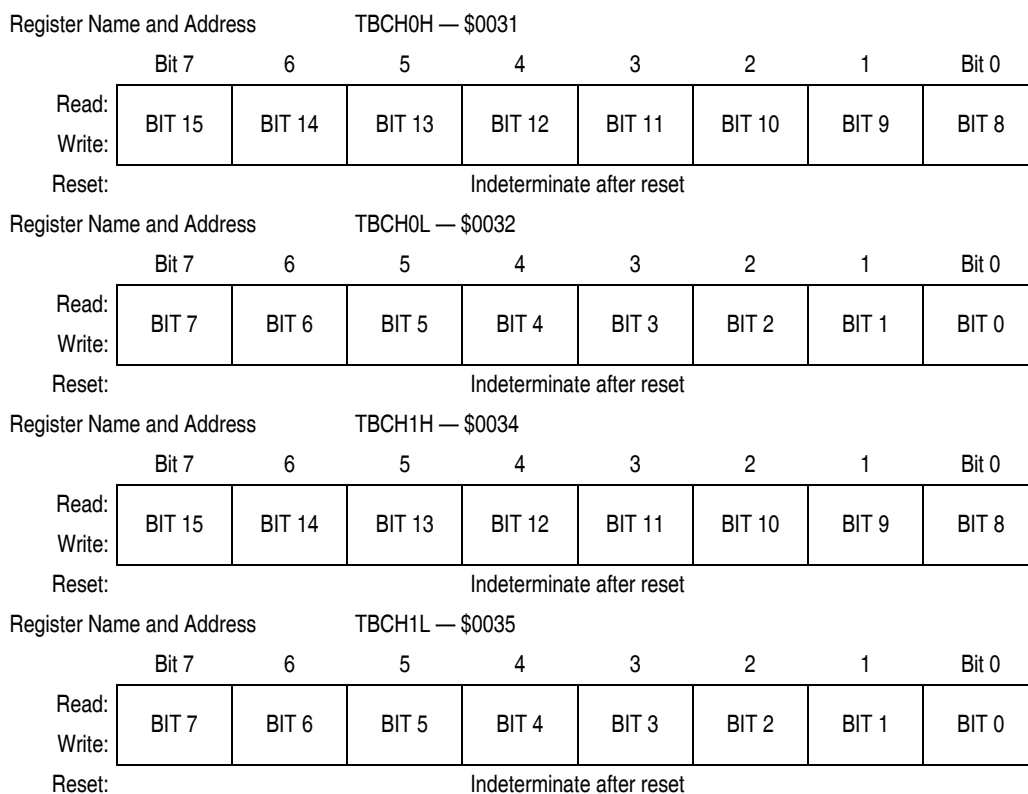


Figure 18-9. TIMB Channel Registers (TBCH0H/L–TBCH1H/L)

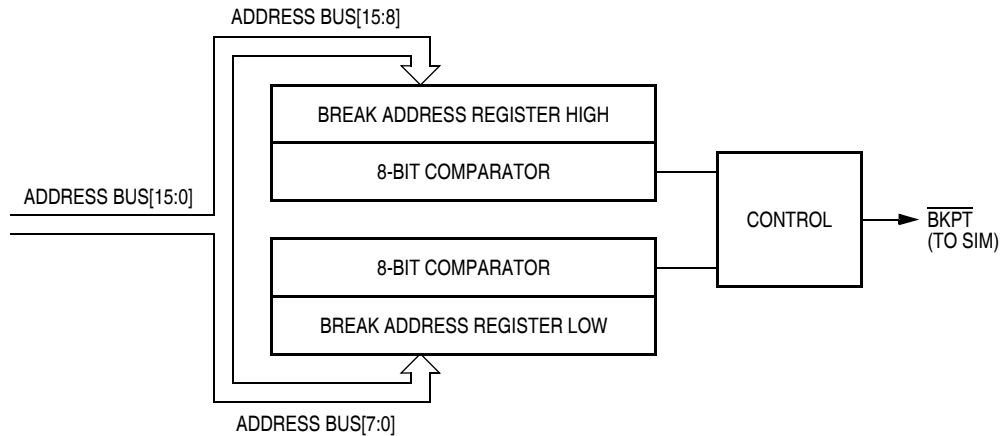


Figure 19-2. Break Module Block Diagram

By updating a break address and clearing the BRKA bit in a break interrupt routine, a break interrupt can be generated continuously.

CAUTION

A break address should be placed at the address of the instruction opcode. When software does not change the break address and clears the BRKA bit in the first break interrupt routine, the next break interrupt will not be generated after exiting the interrupt routine even when the internal address bus matches the value written in the break address registers.

19.2.1.1 Flag Protection During Break Interrupts

The system integration module (SIM) controls whether or not module status bits can be cleared during the break state. The BCFE bit in the break flag control register (SBFCR) enables software to clear status bits during the break state. See [14.8.3 SIM Break Flag Control Register](#) and the “Break Interrupts” subsection for each module.

19.2.1.2 TIM During Break Interrupts

A break interrupt stops the timer counter and inhibits input captures.

19.2.1.3 COP During Break Interrupts

The COP is disabled during a break interrupt when V_{TST} is present on the \overline{RST} pin.

19.2.2 Break Module Registers

These registers control and monitor operation of the break module:

- Break status and control register (BSCR)
- Break address register high (BRKH)
- Break address register low (BRKL)
- Break status register (SBSR)
- Break flag control register (SBFCR)

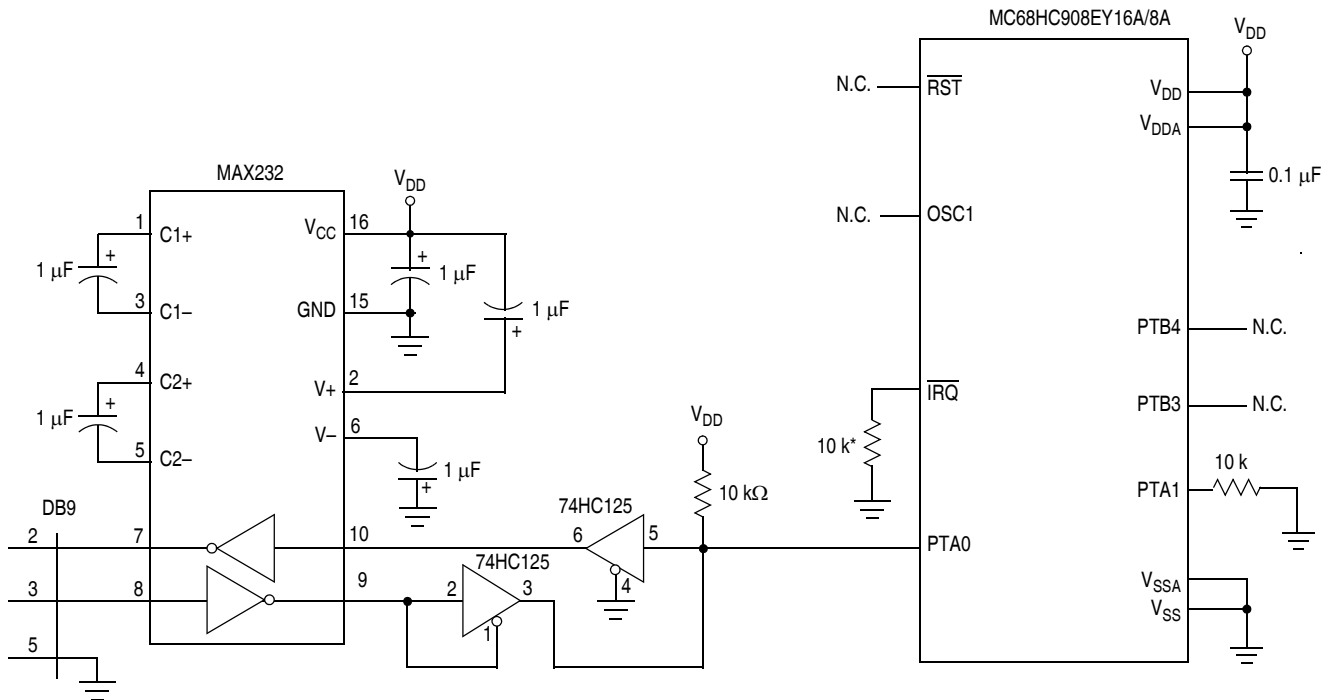


Figure 19-11. Forced Monitor Mode ($V_{\overline{IRQ}} = V_{SS}$)

Enter monitor mode with pin configuration shown in [Table 19-1](#) by pulling \overline{RST} low and then high. The rising edge of \overline{RST} latches monitor mode. Once monitor mode is latched, the levels on the port pins except PTA0 can change.

Once out of reset, the MCU waits for the host to send eight security bytes (see [19.3.2 Security](#)). After the security bytes, the MCU sends a break signal (10 consecutive 0s) to the host, indicating that it is ready to receive a command.

19.3.1.1 Normal Monitor Mode

If V_{TST} is applied to \overline{IRQ} upon monitor mode entry, the internal operating frequency is a divide-by-four of the input clock.

When monitor mode was entered with V_{TST} on \overline{IRQ} , the computer operating properly (COP) is disabled as long as V_{TST} is applied to either \overline{IRQ} or \overline{RST} .

This condition states that as long as V_{TST} is maintained on the \overline{IRQ} pin after entering monitor mode, or if V_{TST} is applied to \overline{RST} after the initial reset to get into monitor mode (when V_{TST} was applied to \overline{IRQ}), then the COP will be disabled. In the latter situation, after V_{TST} is applied to the \overline{RST} pin, V_{TST} can be removed from the \overline{IRQ} pin in the interest of freeing the \overline{IRQ} for normal functionality in monitor mode.

NOTE

While the voltage on \overline{IRQ} is at V_{TST} , the ICG module is bypassed and the external square-wave clock becomes the clock source. Dropping \overline{IRQ} to below V_{TST} will remove the bypass and the MCU will revert to the clock source selected by the ICG (a determined by the settings in the ICG registers).

Interrupts are masked (I bit is set) during a programming operation. When returning from this routine, I bit is restored to the entry condition. If the COP is enabled (COPD = 0), the COP is serviced in this routine. The first COP is serviced at 42 bus cycles after this routine is called in the user software. When the COP is disabled (COPD = 1), this row programming method is the fastest way to program the FLASH.

Entry Condition

H:X — Contains the beginning address in a range.

LADDR — Contains the last address in a range.

CPUSPD — Contains the nearest integer value of f_{op} (in MHz) times 4.

DATA array — Contains the data values to be programmed into FLASH.

Exit Condition

H:X — Contains the address of the next byte after the range just programmed.

[Example 19-5](#) shows how to program one full 32-byte row:

Example 19-5. Programming a Row

```
fProgram: equ  $1009           ;EY16A/8A fProgram jump address

CPUSPD:   equ  $0049           ;Define CPUSPD addrss
LADDR:    equ  $004A           ;Define LADDR address (2 bytes)
DATA:     equ  $004C           ;Define DATA start address

        ldhx  #$0000           ;Index offset into DATA array
        lda   #$AA             ;Initial data value (inverted)
Data_load:
        coma                ;Alternate between $55 and $AA
        sta   DATA,x         ;Fill DATA array, 32 bytes data,
                                ; values to program into FLASH
        aix   #1              ; (ie. 55, AA, 55, AA....)
        cphx  #$20
        bne  Data_load

        mov   #$0A,CPUSPD     ;fop = 2.4576MHz in this example
        ldhx  #$C01F           ;Load last address of the row
        sthx  LADDR           ; to LADDR
        ldhx  #$C000           ;Load beginning address of the
                                ; row to H:X
        jsr   fProgram        ;Call fProgram routine
```

20.8 3V Control Timing

Characteristic ⁽¹⁾	Symbol	Min	Max	Unit
Frequency of operation ⁽²⁾				
Crystal option (EXTSLOW = 1, RINGSEL = 0)	f _{OSC}	32	100	kHz
Crystal option (EXTSLOW = 0, RINGSEL = 1)		1	8	MHz
Crystal option (EXTSLOW = 0, RINGSEL = 0)		8	16	MHz
External clock option (EXTSLOW = 1, RINGSEL = 0) ⁽³⁾		dc ⁽⁴⁾	100	kHz
External clock option (EXTSLOW = 0, RINGSEL = 1)		1	8	MHz
External clock option (EXTSLOW = 0, RINGSEL = 0)		8	16	MHz
Internal operating frequency	f _{OP}	—	4	MHz
Internal operating period (1/f _{OP})	t _{CYC}	250	—	ns
$\overline{\text{RST}}$ input pulse width low ⁽⁵⁾	t _{RL}	200	—	ns
$\overline{\text{IRQ}}$ interrupt pulse width low ⁽⁶⁾ (edge-triggered)	t _{LIH}	200	—	ns
$\overline{\text{IRQ}}$ interrupt pulse period	t _{LIL}	Note ⁽⁷⁾	—	t _{CYC}

1. V_{DD} = 2.7 to 3.3 Vdc, V_{SS} = 0 Vdc, T_A = T_L to T_H; timing shown with respect to 20% V_{DD} and 70% V_{SS}, unless otherwise noted.
2. See [Chapter 8 Internal Clock Generator \(ICG\) Module](#) for more information.
3. No more than 10% duty cycle deviation from 50%
4. Some modules may require a minimum frequency greater than dc for proper operation. See appropriate table for this information.
5. Minimum pulse width reset is guaranteed to be recognized. It is possible for a smaller pulse width to cause a reset.
6. Minimum pulse width is for guaranteed interrupt. It is possible for a smaller pulse width to be recognized.
7. The minimum period is the number of cycles it takes to execute the interrupt service routine plus 1 t_{CYC}.

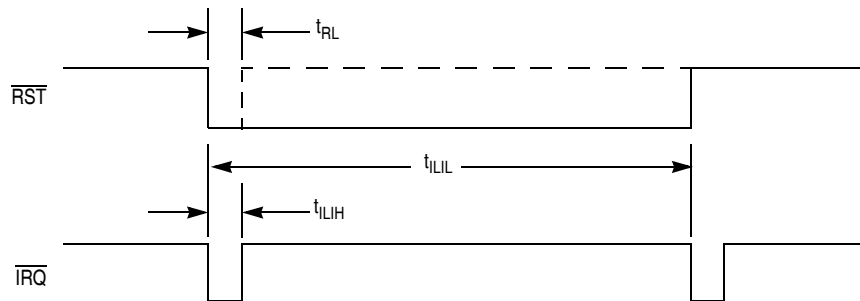


Figure 20-2. $\overline{\text{RST}}$ and $\overline{\text{IRQ}}$ Timing

20.9 Internal Oscillator Characteristics

Characteristic ⁽¹⁾	Symbol	Min	Typ	Max	Unit
Internal oscillator base frequency ^{(2), (3)}	f _{INTOSC}	230.4	307.2	384	kHz
Internal oscillator tolerance	f _{OSC_TOL}	-25	—	+25	%
Internal oscillator multiplier ⁽⁴⁾	N	1	—	127	—

1. V_{DD} = 4.5 to 5.5 Vdc, V_{SS} = 0 Vdc, T_A = -40°C to +125°C, unless otherwise noted
2. Internal oscillator is selectable through software for a maximum frequency. Actual frequency will be multiplier (N) x base frequency.
3. f_{Bus} = (f_{INTOSC} / 4) x N when internal clock source selected
4. Multiplier must be chosen to limit the maximum bus frequency of 8 MHz for 4.5-V operation.